

Supplementary Material

Modulating the Schottky barrier of Pt/PbTiO₃ for efficient piezo-photocatalytic hydrogen evolution

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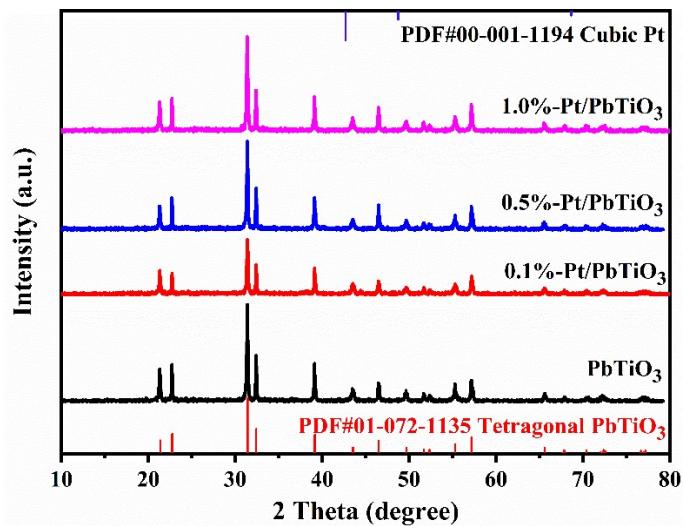


Fig. S1 Typical XRD patterns of bare PbTiO₃, 0.1% Pt/PbTiO₃, 0.5% Pt/PbTiO₃ and 1.0% Pt/PbTiO₃.

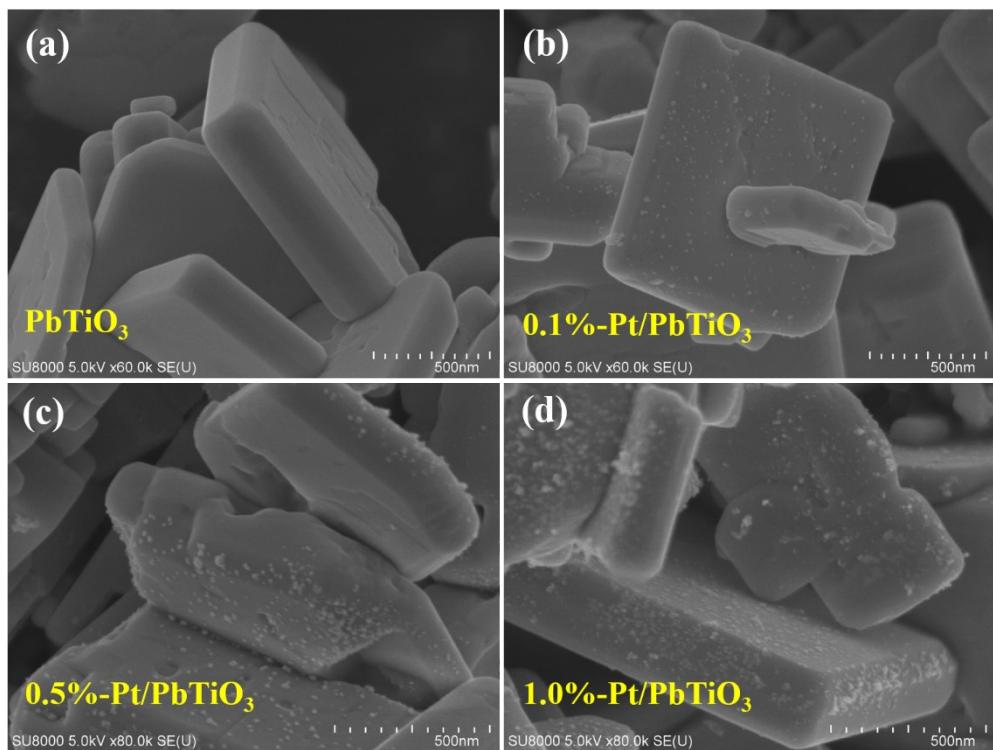


Fig. S2 SEM images of bare PbTiO₃, 0.1% Pt/PbTiO₃, 0.5% Pt/PbTiO₃ and 1.0% Pt/PbTiO₃.

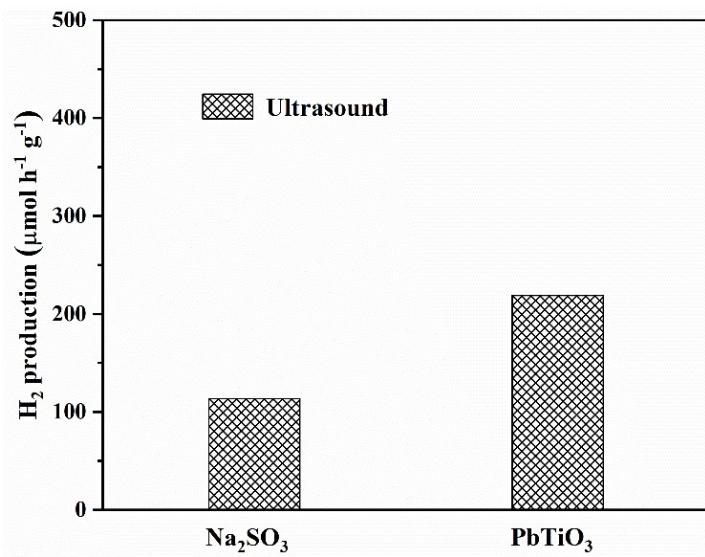


Fig. S3 Comparison diagram of piezocatalytic hydrogen evolution rates.

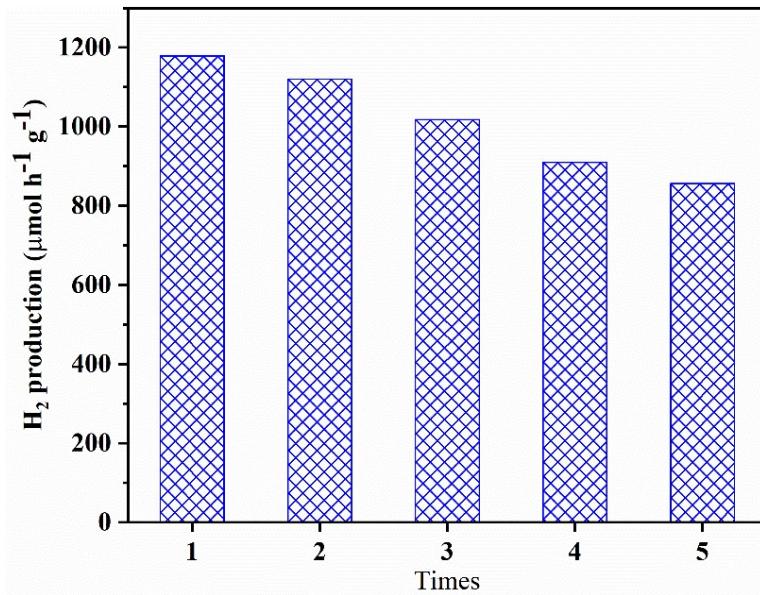


Fig. S4 Time-circle piezo-photocatalytic H₂ evolution rate on 0.5%-Pt/PbTiO₃.

The following formula can be used to calculate the band gap energy for one semiconductor[1].

$$\alpha h\nu = A(h\nu - E_g)^{n/2}$$

Where $h\nu$, α , A, and E_g are light energy, absorption index, constant value, and band-gap energy of semiconductor, respectively. What is more, n relies on the transition type of semiconductor. The n for direct transition is equal to 1, while n is 4 for indirect transition.

Table S1 Related parameters for the calculation of V_p of PbTiO_3

w_3	$T_3[2]$	$d_{33}[3]$	$\varepsilon_0[4]$	$\varepsilon_r[5]$
172 nm (according to PFM image)	1.01×10^5 kPa	70 pm/V	8.85×10^{-12} F/m	550

Because of the different between the work function of Pt and the electron affinity of PbTiO_3 , a Schottky junction forms between the PbTiO_3 nanoplate and Pt-coated tip. The bottom of PbTiO_3 nanoplate was connected to ITO conductive film. Since the piezoelectric polarization charges only existed at the top surface of nanoplate and the bottom surface of nanoplate contact with ITO and the contact between ITO and bottom nanoplate surface was rather large, the influence of the piezopotential on the bottom PbTiO_3 -ITO contact can be neglected. Therefore, it is reasonable to assume that the Schottky barrier formed at the Pt- PbTiO_3 interface and dominates the IV characteristics.

Table S2 Comparison results of H₂ production rate via piezo-photocatalysis

Catalysts	Catalytic Conditions	Sacrificial Agents	Catalytic Activity	Ref.
Bi _{0.5} Na _{0.5} TiO ₃ nanosphere	Ultrasonic (40 kHz, 110 W); Xe lamp (300 W)	Triethanolamine	158 μmol h ⁻¹ g ⁻¹	[6]
PbTiO ₃ -CdS-10%	Ultrasonic (40 kHz, 100 W); Xe lamp (300 W) ($\lambda \geq 420$ nm)	0.1 M Na ₂ S/Na ₂ SO ₃	849 μmol h ⁻¹ g ⁻¹	[7]
KNbO ₃ /MoS ₂ heterostructure	Ultrasonic (40 kHz, 110 W); Xe lamp (300 W)	Triethanolamine	96 μmol h ⁻¹ g ⁻¹	[8]
R3C ZnSnO ₃ Nanowires	Ultrasonic (40 kHz, 250 W); Xe lamp (150 W)	Ethyl alcohol	857 μmol h ⁻¹ g ⁻¹	[9]
ZnO nanowires	Ultrasonic (40 kHz, 50 W); Xe lamp (50 W)	Methanol	1.9 μmol h ⁻¹ g ⁻¹	[10]
TiO ₂ /ZnO nanowires	Ultrasonic (40 kHz, 50 W); Xe lamp (50 W)	Methanol	3.1 μmol h ⁻¹ g ⁻¹	[10]
0.5%-Pt/PbTiO ₃	Ultrasonic (40 kHz, 100 W); $\lambda \geq 400$ nm, Xe lamp (300 W)	0.1 M Na ₂ SO ₃	1181.3 μmol h ⁻¹ g ⁻¹	This work

Reference

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